Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/657,694	WU, JENG-SHYONG
Examiner	Art Unit
Anabel M. Ton	2875

	SEAR	CHED	
Class	Subclass	Date	Examiner
362	84	1/18/2005	ΑТ
	653-656		
	644		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
		•			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
·	DATE	EXMR		
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